

# SPECTRODENSITOME TER SPE75-45B



# SPECTRODENSITOMETER SPE75-45B

Spectrodensitometer has the capability of densitometer and measures color and numeric color differences and widely used in the ink printing

## SPE75-45B SPECTRODENSITOMETER

45/0 geometrical optics structure, comply with CIE, the testing conditions of M O, M 1,M 2, M 3 stipulated by ISO 13655 standard, it can accurately measure various printing density, overprint rate and other printing parameters.

Accurately measure reflectance spectrum, CMYK density and Lab value of the sample;

High-configuration electronic hardware: 3.5-inch TFT true-color screen, capacitive touch screen, concave grating, 256-pixel dual-array CMOS image sensor, etc.;

Perfect combination of the beautiful appearance and the ergonomic structure design;

Optional apertures: Φ2/4/8mm, adapt to more samples;

Large-capacity storage space, over 20,000 test data

Combined LED light sources with long life and low power consumption, including UV light;

USB/Blue2.1 dual communication mode is widely useful;

Especially suitable for process control and quality control of printing plants;

PC software has powerful function expansion.

### **SPECIFICATIONS**

| Model                       | SPE75-45B   |
|-----------------------------|---|
| Optical Geometry            | 45/0(45 ring-shaped illumination, 0 degree viewing angle)   |
| Standards compliant         | ISO 5-4,CIE No.15 Compliance with ISO 13655 measurement conditions; M0 (CIE Light Soure A) M1 (CIE Light Soure D50) M2 (Excluding UV light source) M3 (M2+Polarized light filter)                                 |
| Illuminant                  | D65,A,C,D50,D55,D65,D75,F2(CWF),F7(DLP),F11(TL84),F12(TL83/U30),F1,F3,F4,F5,F6,F8,F9,F10(TPL5)  |
| Spectral Mode               | Concave Grating   |
| Sensor                      | 256 Image Element Double Array CMOS Image Sensor  |
| Wavelength Pitch            | 10 nm   |
| Semi-bandwidth              | 10 nm   |
| Density Standards           | ISO Status A, E, I, T   |
| Density index               | Density value, density difference, dot area, dot enlargement, overprint, printing characteristics, printing contrast, tone error and gray scale, density scanning Customized one aperture:Φ2mm,Φ4mm,Φ8mm optional |
| color space                 | CIE LAB,XYZ,Yxy,LCh,CIE LUV,HunterLAB   |
| Color Difference<br>Formula | $\Delta$ E*ab, $\Delta$ E*94, $\Delta$ E*00, $\Delta$ E*uv, $\Delta$ E*cmc(2:1), $\Delta$ E*cmc(1:1), $\Delta$ E(Hunter)  |
| Other Colorimetric data     | WI(ASTM E313,CIE/ISO,AATCC,Hunter), YI(ASTM D1925,ASTM 313), MI (Metamerism Index),Opacity  |
| Observer                    | 2° / 10°  |
| Measurement Time            | About 1.5s  |
| Repeatability               | Density: Within 0.01 D Chromaticity value: within $\Delta E^*$ ab 0.03 (When a white calibration plate is measured 30 times at 5 second intervals after white calibration)  |
| Inter-instrument agreement  | Within ΔE*ab 0.18 (Average for 12 BCRA Series II color tiles)   |
| Measurement<br>Method       | Single Measurement, Average Measurement(2-99)   |
| Interface                   | USB, Bluetooth  |

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### **Labstac LLC**

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